Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/714,153	JAIN ET AL.	
Examiner	Art Unit	
Isaac T. Tecklu	2192	

SEARCHED					
Class	Subclass	Date	Examiner		
717	101, 127, 128	3/27/2007	ΙΤ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)
	DATE	EXMR
Searched EAST all database	9/26/2007	ΙΤ
Google	9/25/2007	ΙΤ
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